

SLUS896A-AUGUST 2009-REVISED AUGUST 2009

# CURRENT MODE PWM CONTROLLER (KNOWN GOOD DIE)

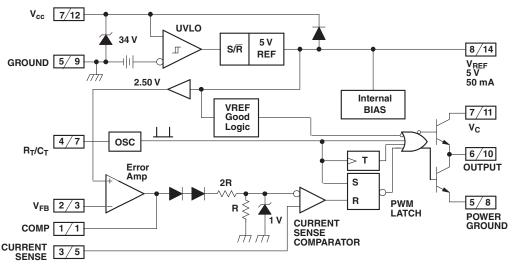
### FEATURES

- -55°C to 125°C Known Good Die
- Controlled Baseline
- Optimized For Off-line and DC-to-DC Converters
- Low Start-Up Current (<1 mA)
- Automatic Feed Forward Compensation
- Pulse-by-Pulse Current Limiting
- Enhanced Load Response Characteristics
- Under-Voltage Lockout With Hysteresis
- Double Pulse Suppression
- High Current Totem Pole Output
- Internally Trimmed Bandgap Reference
- 500-kHz Operation
- Low R<sub>o</sub> Error Amp

### DESCRIPTION

The UC1843 family of control devices provides the necessary features to implement off-line or dc-to-dc fixed frequency current mode control schemes with a minimal external parts count. Internally implemented circuits include under-voltage lockout featuring start up current less than 1 mA, a precision reference trimmed for accuracy at the error amp input, logic to insure latched operation, a PWM comparator which also provides current limit control, and a totem pole output stage designed to source or sink high peak current. The output stage, suitable for driving N-Channel MOSFETs, is low in the off state. The under-voltage lockout threshold is 8.4 V and maximum duty cycle range is around 100%.

### **BLOCK DIAGRAM**



Note 1: A/B A = DIL-8 Pin NumberB = SO-14 and CFP-14 Pin Number

#### **ORDERING INFORMATION**<sup>(1)</sup>

T <sub>A</sub>	PACKAGE <sup>(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–55°C to 125°C	KGD	UC1843KGD1	NA

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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SLUS896A-AUGUST 2009-REVISED AUGUST 2009



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### BARE DIE INFORMATION

DIE THICKNESS	BACKSIDE FINISH	BACKSIDE POTENTIAL	BOND PAD METALLIZATION COMPOSITION		
15 mils.	Silicon with backgrind	GND	Al-Si-Cu (0.5%)		
	b	a c	_		

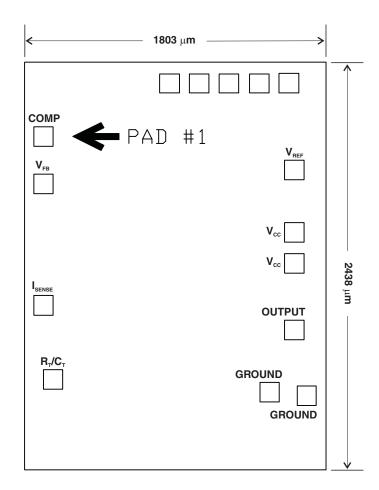
# Origin

#### BOND PAD COORDINATES (in Mils)

DESCRIPTION	PAD NUMBER	а	b	С	d
COMP	1	78.70	63.40	82.90	67.60
V <sub>FB</sub>	2	70.60	63.40	74.80	67.60
I <sub>SENSE</sub>	3	39.40	63.40	43.60	67.60
R <sub>T</sub> /C <sub>T</sub>	4	18.60	61.20	22.60	65.60
GROUND	5	17.80	11.70	22.00	15.90
GROUND	6	17.40	3.90	21.80	8.10
OUTPUT	7	32.60	6.40	36.80	10.60
V <sub>CC</sub>	8	47.50	6.40	51.70	10.60
V <sub>CC</sub>	9	54.60	6.40	58.80	10.60
V <sub>REF</sub>	10	68.70	6.40	72.90	10.60
NC	TESTPAD	87.10	6.30	90.80	10.30
NC	TESTPAD	87.10	12.60	90.80	16.60
NC	TESTPAD	87.10	18.00	90.80	22.00
NC	TESTPAD	87.10	24.30	90.80	28.30
NC	TESTPAD	87.10	30.60	90.80	34.60



SLUS896A-AUGUST 2009-REVISED AUGUST 2009



### **ABSOLUTE MAXIMUM RATINGS**

		UNIT
Supply voltage	Low impedance source	30 V
Supply voltage	I <sub>CC</sub> < 30 mA	Self Limiting
Output current		±1 A
Output energy (capacitive lo	ad)	5 µJ
Analog inputs (Pins 2, 3)		–0.3 V to 6.3 V
Error amp output sink currer	t	10 mA
Storage temperature range	erature range -65°C	
Junction temperature range		–55°C to 150°C

### **ELECTRICAL CHARACTERISTICS**

SLUS896A-AUGUST 2009-REVISED AUGUST 2009

Unless otherwise stated, these specifications apply for  $-55^{\circ}C \le T_A \le 125^{\circ}C$ ;  $V_{CC} = 15 V^{(1)}$ ;  $R_T = 10 \text{ kW}$ ;  $C_T = 3.3 \text{ nF}$ ,  $T_A = T_J$ .

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
REFERENCE SECTION		L		<sup>1</sup>	
Output Voltage	$T_{\rm J} = 25^{\circ}$ C, $I_{\rm O} = 1$ mA	4.95	5.00	5.05	V
Line Regulation	$12 \le V_{IN} \le 25 V$		6	20	
Load Regulation	$1 \le I_0 \le 20 \text{ mA}$		6	25	mV
Temperature Stability	See <sup>(2)(3)</sup>		0.2	0.4	mV/°C
Total Output Variation	Line, load, tempature (2)	4.9		5.1	V
Output Noise Voltage	10 Hz≤ f ≤ 10 kHz, $T_J = 25^{\circ}C^{(2)}$		50		μV
Long Term Stability	$T_A = 125^{\circ}C$ , 1000 Hrs <sup>(2)</sup>		5	25	mV
Output Short Circuit		-30	-100	-180	mA
OSCILLATOR SECTION				·	
Initial Accuracy	$T_{\rm J} = 25^{\circ} {\rm C}^{(4)}$	47	52	57	kHz
Voltage Stability	$12 \le V_{CC} \le 25 V$		0.2%	1%	
Temperature Stability	$T_{MIN} \le T_A \le T_{MAX} $ <sup>(2)</sup>		5%		
Amplitude	V <sub>PIN</sub> 4 peak-to-peak <sup>(2)</sup>		1.7		V
ERROR AMP SECTION				·	
Input Voltage	V <sub>PIN 1</sub> = 2.5 V	2.45	2.50	2.55	V
Input Bias Current			-0.3	-1	μA
A <sub>VOL</sub>	$2 \le V_0 \le 4 V$	65	90		dB
Unity Gain Bandwidth	$T_{\rm J} = 25^{\circ} C^{(2)}$	0.7	1		MHz
PSRR	$12 \le V_{CC} \le 25 V$	60	70		dB
Output Sink Current	V <sub>PIN 2</sub> = 2.7 V, V <sub>PIN 1</sub> = 1.1 V	2	6		
Output Source Current	V <sub>PIN 2</sub> = 2.3 V, V <sub>PIN 1</sub> = 5 V	-0.5	-0.8		mA
V <sub>OUT</sub> High	$V_{PIN 2}$ = 2.3 V, $R_L$ = 15 k $\Omega$ to ground	5	6		V
V <sub>OUT</sub> Low	$V_{PIN 2} = 2.7 \text{ V}, \text{ R}_{L} = 15 \text{ k}\Omega \text{ to Pin 8}$		0.7	1.1	v
CURRENT SENSE SECTION				·	
Gain	See <sup>(5)(6)</sup>	2.85	3	3.15	V/V
Maximum Input Signal	$V_{PIN 1} = 5 V^{(5)}$	0.9	1	1.1	V
PSRR	$12 \le V_{CC} \le 25 \ V^{(2)(5)}$		70		dB
Input Bias Current			-2	-10	μΑ
Delay to Output	$V_{PIN 3} = 0 V \text{ to } 2 V$ <sup>(2)</sup>		150	300	ns
OUTPUT SECTION					
	I <sub>SINK</sub> = 20 mA		0.1	0.4	
Output Low Level	I <sub>SINK</sub> = 200 mA		1.5	2.2	V
	I <sub>SOURCE</sub> = 20 mA	13	13.5		v
Output High Level	I <sub>SOURCE</sub> = 200 mA	12	13.5		
Rise Time	$T_J = 25^{\circ}C, C_L = 1 \text{ nF}^{(2)}$		50	150	<b>F2</b>
Fall Time	$T_J = 25^{\circ}C, C_L = 1nF^{(2)}$		50	150	ns

Adjust  $V_{CC}$  above the start threshold before setting at 15 V. (1)

These parameters, although specified, are not 100% tested in production.

(2) (3) Temperature stability, sometimes referred to as average temperature coefficient, is described by the equation:

Temp Stability = 
$$\frac{V_{REF}(max) - VREF(min)}{T_{REF}(max) - T_{REF}(min)}$$

The stability =  $\frac{1}{TJ(max) - TJ(min)} V_{REF(max)}$  and  $V_{REF(min)}$  are the maximum and minimum reference voltages measured over the appropriate temperature range. Note that the extremes in voltage do not necessarily occur at the extremes in temperature.

Output frequency equals oscillator frequency (4)

Parameter measured at trip point of latch with  $V_{PIN 2} = 0$ . (5) ).8 V

(6) Gain defined as: 
$$A = \frac{\Delta V \Gamma I V T}{\Delta V P I N 3}, 0 \le V P I N 3 \le 0$$



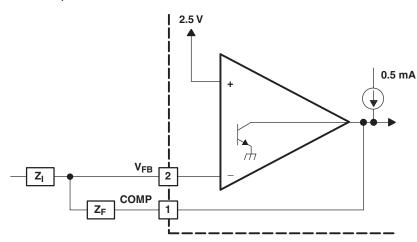
### **ELECTRICAL CHARACTERISTICS (continued)**

Unless otherwise stated, these specifications apply for  $-55^{\circ}C \le T_{A} \le 125^{\circ}C$ ;  $V_{CC} = 15$  V;  $R_{T} = 10$  kW;  $C_{T} = 3.3$  nF,  $T_{A} = T_{J}$ .

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
UNDER-VOLTAGE LOCKOUT SECTION	l l				
Start Threshold		7.8	8.4	9.0	
Min. Operating Voltage After Turn On		7.0	7.6	8.2	V
PWM SECTION					
Maximum Duty Cycle		95%	97%	100%	
Minimum Duty Cycle				0%	
TOTAL STANDBY CURRENT					
Start-Up Current			0.5	1	
Operating Supply Current	V <sub>PIN 2</sub> = V <sub>PIN 3</sub> = 0 V		11	17	mA
V <sub>CC</sub> Zener Voltager	I <sub>CC</sub> = 25 mA	30	34		V

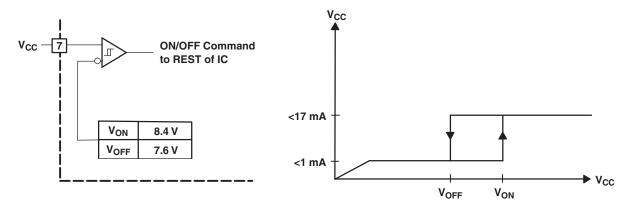
#### ERROR AMP CONFIGURATION

Error amp can source or sink up to 0.5 mA.



#### UNDER-VOLTAGE LOCKOUT

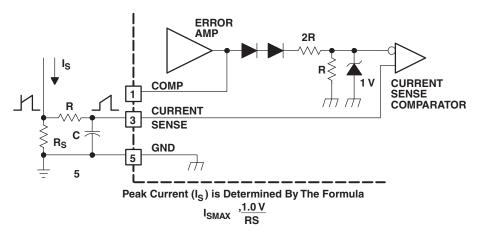
During under-voltage lock-out, the output drive is biased to sink minor amounts of current. Pin 6 should be shunted to ground with a bleeder resistor to prevent activating the power switch with extraneous leakage currents.



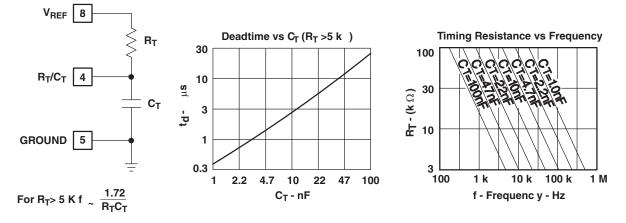
SLUS896A-AUGUST 2009-REVISED AUGUST 2009

### **CURRENT SENSE CIRCUIT**

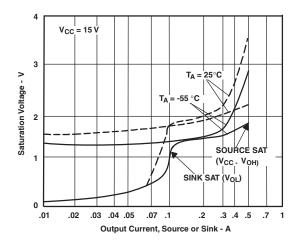
A small RC filter may be required to suppress switch transients.



#### **OSCILLATOR SECTION**



### **OUTPUT SATURATION CHARACTERISTICS**

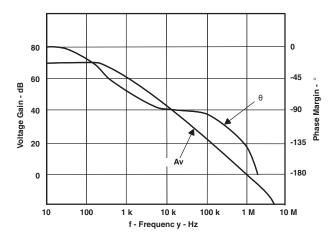


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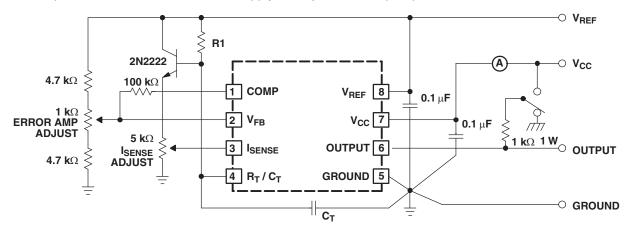
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### ERROR AMPLIFIER OPEN-LOOP FREQUENCY RESPONSE



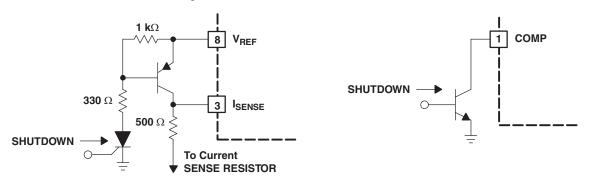
# **OPEN-LOOP LABORATORY FIXTURE**

High peak currents associated with capacitive loads necessitate careful grounding techniques. Timing and bypas capacitors should be conected close to pin 5 in a single point ground. The transistor and 5k potentiometer are used to sample the oscillator waveform and apply an adjustable ramp to pin 3.

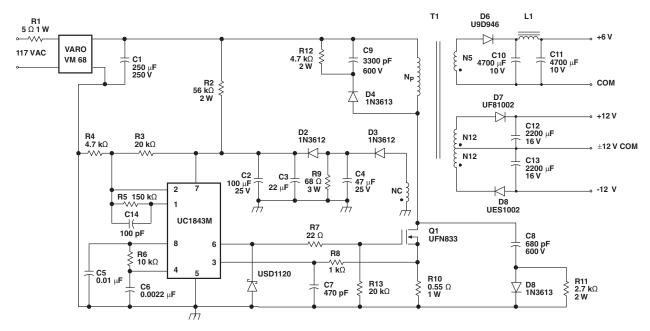


### SHUTDOWN TECHNIQUES

Shutdown of the UC1843 can be accomplished by two methods; either raise pin 3 above 1 V or pull pin 1 below a voltage two diode drops above ground. Either method causses the output of the PWM comparator to be high (refer to block diagram). The PWM latch is reset dominant so that the output will remain low until the next clock cycle after the shutdown condition at pin 1 and/or 3 is removed. In one example, an externally latched shutdown may be accomplished by adding an SCR which will be reset by cycling  $V_{CC}$  below the lower UVLO threshold. At this pint the reference turns off, allowing the SCR to reset.



### **OFFLINE FLYBACK REGULATOR**

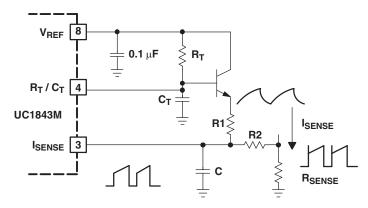


#### **Power Supply Specifications**

- 1. Input Voltages
  - a. 5VAC to 130VA (50 Hz/60 Hz)
- 2. Line Isolation: 3750 V
- 3. Switchng Frequency: 40 kHz
- 4. Efficiency at Full Load 70%
- 5. Output Voltage:
  - a. +5 V, ±5%; 1A to 4A load Ripple voltage: 50 mV P-P Max
  - b. +12 V, ±3%; 0.1A to 0.3A load
    Ripple voltage: 100 mV P-P Max
  - c. -12 V, ±3%; 0.1A to 0.3A load Ripple voltage: 100 mV P-P Max

### **SLOPE COMPENSATION**

A fraction of the oscillator ramp can be resistively summed with the current sense signal to provide slope compensation for converters requiring duty cycles over 50%.





24-Jan-2013

### PACKAGING INFORMATION

Orderable Devic	e Status	Package Type	•	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
UC1843MKGD1	ACTIVE	XCEPT	KGD	0	100	TBD	Call TI	N / A for Pkg Type	-55 to 125		Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

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**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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